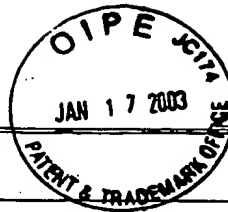


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 216792US		SERIAL NO. New US PCT application based on PCT/JP00/03579	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Kengo MYOSHI et al.			
				FILING DATE Herewith		GROUP 2623	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
/NV/	AO	1-307385	12/12/89	JP		No	
/NV/	AP	10-66051	03/06/98	JP		No	
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner /Ngoc Vu/				Date Considered 03/12/2007			
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216792US2PCTSERIAL NO.
09/926,689

LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
Kengo MIYOSHI, et al.FILING DATE
December 3, 2001GROUP
2661 2623

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
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FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
/NV/	AO	10-215445	08/11/98	JAPAN (with English Abstract)		X
	AP	9-510071	10/07/97	JAPAN (with English Abstract)		X
	AQ	11-4426	01/06/99	JAPAN (with English Abstract)		X
	AR	10-174084	06/26/98	JAPAN (with English Abstract)		X
	AS	63-19992	01/27/88	JAPAN (with English Abstract)		X
	AT	63-294144	11/30/88	JAPAN (with English Abstract)		X
	AU					
	AV					

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

/NV/	AW	Patent Abstracts of Japan, JP 01-307385, December 12, 1989				
/NV/	AX	Patent Abstracts of Japan, JP 10-066051, March 6, 1998				
	AY					
	AZ					<input type="checkbox"/> Additional References sheet(s) attached

Examiner /Ngoc Vu/

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